

Notice of References Cited	Application/Control No. 10/535,740	Applicant(s)/Patent Under Reexamination HECKEL ET AL.	
	Examiner Adi Amrany	Art Unit 2836	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,709,200	11-1987	Ochiai, Hitoshi	320/166
*	B	US-6,777,912	08-2004	Yamada et al.	320/118
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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